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Fairchild Semiconductor FMB100

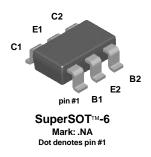
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# **FMB100**



# **NPN Multi-Chip General Purpose Amplifier**

This device is designed for general purpose amplifier applications at collector currents to 300 mA. Sourced from Process 10.

### **Absolute Maximum Ratings\***

T<sub>A</sub> =25°C unless otherwise noted

Symbol	Parameter	Value	Units
$V_{CEO}$	Collector-Emitter Voltage	45	V
V <sub>CBO</sub>	Collector-Base Voltage	75	V
V <sub>EBO</sub>	Emitter-Base Voltage	6.0	V
Ic	Collector Current - Continuous	500	mA
T <sub>J</sub> , T <sub>stg</sub>	Operating and Storage Junction Temperature Range	-55 to +150	°C

<sup>\*</sup>These ratings are limiting values above which the serviceability of any semiconductor device may be impaired.

### Thermal Characteristics T<sub>a</sub>=25°C unless otherwise noted

Symbol	Characteristic	Max	Units
		FMB100	
P <sub>D</sub>	Total Device Dissipation	700	mW
	Derate above 25°C	5.6	mW/°C
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	180	°C/W

NOTES:

1) These ratings are based on a maximum junction temperature of 150 degrees C.

2) These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.



# **NPN Multi-Chip General Purpose Amplifier**

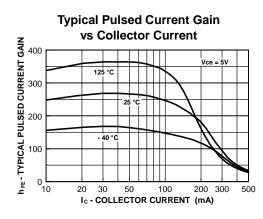
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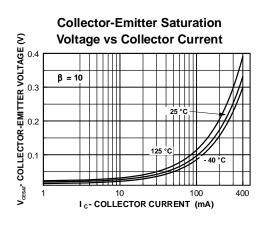
#### **Flectrical Characteristics**

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
OFF CHAI	RACTERISTICS					
BV <sub>CBO</sub>	Collector-Base Breakdown Voltage	$I_C = 10 \mu\text{A},  I_B = 0$	75			V
BV <sub>CEO</sub>	Collector-Emitter Breakdown Voltage*	$I_C = 1 \text{ mA}, I_E = 0$	45			V
BV <sub>EBO</sub>	Emitter-Base Breakdown Voltage	$I_E = 10  \mu A,  I_C = 0$	6.0			V
I <sub>CBO</sub>	Collector Cutoff Current	V <sub>CB</sub> = 60 V			50	nA
I <sub>CES</sub>	Collector Cutoff Current	V <sub>CE</sub> = 40 V			50	nA
I <sub>EBO</sub>	Emitter Cutoff Current	V <sub>EB</sub> = 4 V			50	nA
h <sub>FE</sub>	DC Current Gain	$I_C = 100 \mu\text{A},  V_{CE} = 1.0 \text{V}$	80		450	
h <sub>FE</sub>	DC Current Gain	$I_C = 10 \text{ mA}, V_{CE} = 1.0 \text{ V}$	100		450	
		$\begin{split} I_C &= 10 \text{ mA}, \ V_{CE} = 1.0 \ V \\ I_C &= 100 \text{ mA}, \ V_{CE} = 1.0 \ V^* \\ I_C &= 150 \text{ mA}, \ V_{CE} = 5.0 \ V^* \end{split}$			350	V
V <sub>CE(sat)</sub>	DC Current Gain  Collector-Emitter Saturation Voltage	$I_C = 10 \text{ mA}, V_{CE} = 1.0 \text{ V}$ $I_C = 100 \text{ mA}, V_{CE} = 1.0 \text{ V}^*$	100 100			V
V <sub>CE(sat)</sub>		$\begin{split} &I_C = 10 \text{ mA, } V_{CE} = 1.0 \text{ V} \\ &I_C = 100 \text{ mA, } V_{CE} = 1.0 \text{ V}^* \\ &I_C = 150 \text{ mA, } V_{CE} = 5.0 \text{ V}^* \\ &I_C = 10 \text{ mA, } I_B = 1.0 \text{ mA} \end{split}$	100 100		350	
V <sub>CE(sat)</sub>	Collector-Emitter Saturation Voltage	$\begin{split} &I_C = 10 \text{ mA}, \ V_{CE} = 1.0 \ V \\ &I_C = 100 \text{ mA}, \ V_{CE} = 1.0 \ V^* \\ &I_C = 150 \text{ mA}, \ V_{CE} = 5.0 \ V^* \\ \\ &I_C = 10 \text{ mA}, \ I_B = 1.0 \text{ mA} \\ &I_C = 200 \text{ mA}, \ I_B = 20 \text{ mA}^* \\ \\ &I_C = 10 \text{ mA}, \ I_B = 1.0 \text{ mA} \end{split}$	100 100		350 0.2 0.4 0.85	V
V <sub>CE(sat)</sub> V <sub>BE(sat)</sub>	Collector-Emitter Saturation Voltage  Base-Emitter Saturation Voltage  GNAL CHARACTERISTICS  Current Gain - Bandwidth Product	$\begin{split} &I_C = 10 \text{ mA}, \ V_{CE} = 1.0 \ V \\ &I_C = 100 \text{ mA}, \ V_{CE} = 1.0 \ V^* \\ &I_C = 150 \text{ mA}, \ V_{CE} = 5.0 \ V^* \\ \\ &I_C = 10 \text{ mA}, \ I_B = 1.0 \text{ mA} \\ &I_C = 200 \text{ mA}, \ I_B = 20 \text{ mA}^* \\ \\ &I_C = 10 \text{ mA}, \ I_B = 1.0 \text{ mA} \end{split}$	100 100	300	350 0.2 0.4 0.85	V V V
V <sub>CE(sat)</sub>	Collector-Emitter Saturation Voltage  Base-Emitter Saturation Voltage  GNAL CHARACTERISTICS	$\begin{split} &I_C = 10 \text{ mA, } V_{CE} = 1.0 \text{ V} \\ &I_C = 100 \text{ mA, } V_{CE} = 1.0 \text{ V}^* \\ &I_C = 150 \text{ mA, } V_{CE} = 5.0 \text{ V}^* \\ &I_C = 10 \text{ mA, } I_B = 1.0 \text{ mA} \\ &I_C = 200 \text{ mA, } I_B = 20 \text{ mA}^* \\ &I_C = 10 \text{ mA, } I_B = 1.0 \text{ mA} \\ &I_C = 200 \text{ mA, } I_B = 20 \text{ mA}^* \\ \end{split}$	100 100	300	350 0.2 0.4 0.85	V

<sup>\*</sup>Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2.0%

### **Typical Characteristics**



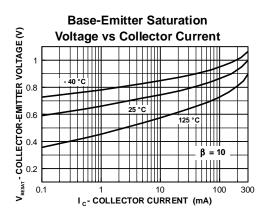


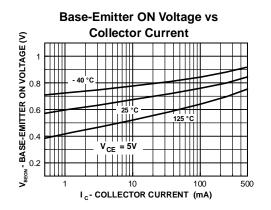


# **NPN Multi-Chip General Purpose Amplifier**

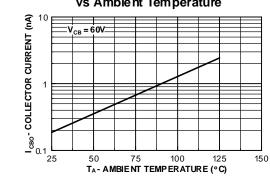
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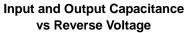
### Typical Characteristics (continued)

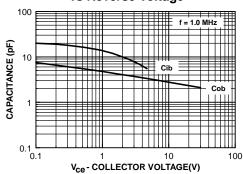




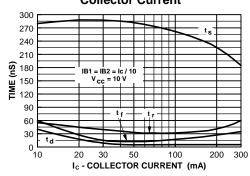
# Collect or-Cutoff Current vs Ambient Temperature



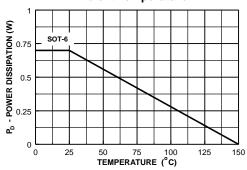




Switching Times vs Collector Current



Power Dissipation vs Ambient Temperature





# Distributor of Fairchild Semiconductor: Excellent Integrated System Limited Datasheet of FMB100 - TRANS NPN 45V 0.5A SSOT-6

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